

<b>Notice of References Cited</b>		Application/Control No. 10/538,524	Applicant(s)/Patent Under Reexamination KIYAMA ET AL.	
		Examiner Andrew St.Clair	Art Unit 3749	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,545,307 A	10-1985	Morita et al.	110/264
*	B	US-5,231,937 A	08-1993	Kobayashi et al.	110/262
*	C	US-5,662,464 A	09-1997	LaRose et al.	431/8
*	D	US-5,727,480 A	03-1998	Garcia-Mallol, Juan Antonio	110/203
*	E	US-5,915,310 A	06-1999	Hura et al.	110/345
*	F	US-6,145,454 A	11-2000	Barna, Joseph J.	110/347
*	G	US-6,280,695 B1	08-2001	Lissianski et al.	423/239.1
*	H	US-6,357,367 B1	03-2002	Breen et al.	110/345
*	I	US-2002/0064742 A1	05-2002	Ligasacchi et al.	431/190
*	J	US-2003/0099913 A1	05-2003	Kobayashi et al.	431/10
*	K	US-2006/0090677 A1	05-2006	Taniguchi et al.	110/265
*	L	US-2006/0115779 A1	06-2006	Yamamoto et al.	431/115
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.